## APPROVAL SHEET

| Customer | Name | $:$ |
| :--- | :--- | :--- |
| Customer $\mathrm{P} / \mathrm{N}$ | $:$ |  |
| Frequency | $: 12.000000$ | MHz |
| Aker Approved P/N: CXA-012000-3F4D40 |  |  |
| Aker MPN | $:$ CXA-012000-3F4D40 |  |
| Rev. | $: 1$ |  |
| ISSUE DATE | $:$ Jul.16.2019 |  |


| APPROVED | CHECKED | PREPARED |  |
| :---: | :---: | :---: | :---: |
| Le~ | Sandy |  |  |
| APPROVED BY CUSTOMER |  |  |  |
|  |  |  |  |

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Web: www.aker.com.tw

| Rev. | Date | Reviser | Revise contents |
| :---: | :---: | :---: | :---: |
| 1 | $2019 / 7 / 16$ | Sandy | Initial Released |
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## SMD CRYSTAL SPECIFICATION

## 1. ELECTRICAL CHARACTERISTICS

■ Standard atmospheric conditions
Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature : $25 \pm 5^{\circ} \mathrm{C}$
Relative humidity : 40\%~70\%

If there is any doubt about the results, measurement shall be made within the following limits :
Ambient temperature : $25 \pm 3{ }^{\circ} \mathrm{C}$
Relative humidity : 40\%~70\%

■ AKER Model : CXA-321
■ Oscillation Model : Fundamental
■ Cutting Model : AT CUT
■ Measurement Equipment : 350A(Measured FL)
■ Insulation Resistance : More than 500M ohms at DC 100 V

| Parameters | Symbol | Electrical Spec |  |  |  | Notes |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. | Units. |  |
| Nominal Frequency | FL | 12.000000 |  |  | MHz |  |
| Frequency Tolerance |  | $\pm 10$ |  |  | ppm | at $25^{\circ} \mathrm{C} \pm 3^{\circ} \mathrm{C}$ |
| Frequency Stability |  | $\pm 20$ |  |  | ppm | Operating Temp (Refer $25^{\circ} \mathrm{C}$ ) |
| Load Capacitance | CL | 20 |  |  | pF |  |
| Aging |  | $\pm 3$ |  |  | ppm | First Year |
| Operating Temperature |  | -40 | $\sim$ | 85 | ${ }^{\circ} \mathrm{C}$ |  |
| Storage Temperature Range |  | -55 | $\sim$ | 125 | ${ }^{\circ} \mathrm{C}$ |  |
| Drive Level | DL |  |  | 100 | uW |  |
| Effective Resistance Rr | Rr |  |  | 100 | $\Omega$ |  |
| Shunt Capacitance | C0 |  |  | 5 | pF |  |

[^0]|  | CUST. P/N: $\quad$ Aker Approved P/N : CXA-012000-3F4D40 |  |  |
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|  | PREPARED | : Sandy | REV . : 1 |

## 2.MARKING:



AKER LOGO. $\longrightarrow$ Production line code

NOTE 1 :

| CODE | CL | CODE | CL | CODE | CL | CODE | CL |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | OpF | 9 | 14. ${ }^{\text {F }}$ | K | 9.5pF | U | 8.5.5 |
| 1 | 160F | A | 32 pF | L | 19.5p | V | 24. F |
| 2 | 22 FF | B | 27 pF | M | 2.55 p | W | 4 p F |
| 3 | 1.5.F | C | 8 p F | N | 33pF | X | 39pF |
| 4 | 200.F | D | 37 FF | P | $7{ }_{7} \mathrm{~F}$ | Y | 26 pF |
| 5 | 30 pF | E | 25 pF | Q | 15.5.5F | 2 | 7.2 pF |
| 6 | 18\% F | F | 35p | R | 12.5.5 | a | 17\%F |
| 7 | 12p F | G | 13.FF | S | $11 . \mathrm{p}$ | $b$ | 9.85p ${ }^{\text {F }}$ |
| 8 | 10pF | H | 9pF | T | $60^{2}$ | d | 5 pF |

3. DIMENSION :

| Year | 2007 | 2008 | 2009 | 2010 |
| :---: | :---: | :---: | :---: | :---: |
|  | 2011 | 2012 | 2013 | 2014 |
|  | 2015 | 2016 | 2017 | 2018 |
|  | 2019 | 2020 | 2021 | 2022 |
|  | 2023 | 2024 | 2025 | 2026 |
| JAN | A | N | a | n |
| FEB | B | P | b | p |
| MAR | C | Q | c | q |
| APR | D | R | d | r |
| MAY | E | S | e | s |
| JUN | F | T | f | t |
| JUL | G | U | g | u |
| AUG | H | V | h | v |
| SEP | J | W | j | w |
| OCT | K | X | k | x |
| NOV | L | Y | l | y |
| DEC | M | Z | m | z |

( Unit : mm )

<BOTTOM $>$

<SIDE>

<SUGGESTED LA YOUT>


| Accurate Kinetic Energy | CUST. P/N |  |  |
| :---: | :---: | :---: | :---: |
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## 4. STRUCTURE ILLUSTRATION



| COMPONENTS |  | MATERIALS | COMPONENTS |  | MATERIALS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| A | Base (Package) | Ceramic( $\left.\mathrm{Al}_{2} \mathrm{O}_{3}\right)+\mathrm{Kovar}(\mathrm{Fe} / \mathrm{Co} / \mathrm{Ni})$ | D | Electrode | $\mathrm{Cr} / \mathrm{Ag}$ |
| B | Conductive adhesive | $\mathrm{Ag} /$ Silicon resin | E | Lid | $\mathrm{Fe} / \mathrm{Co} / \mathrm{Ni}$ |
| C | Crystal blank | $\mathrm{SiO}_{2}$ |  |  |  |


|  | CUST. P/N : |  |  |  |
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## 5. PACKING:

TAPE SPECIFICATION
( Unit : mm )


OUTLINE DIMENSION
( Unit : mm )


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## 6. COVER TAPE ADHESION STRENGTH :


*** In the case, the cover tape is pulled off under the above conditions, the cover tape adhesi on strength should be $10.2 \mathrm{~g} \sim 71.4 \mathrm{~g}$ Plastic tape: $10.2 \mathrm{~g} \sim 71.4 \mathrm{~g}$
(Cover tape adhesi on strength)

## 7. SOLDERING REFLOW PROFILE



| CUST. P/N |  |  |
| :---: | :---: | :---: |
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## 8. PACKING :



$$
\text { BOX = } 3000 \text { PCS / REEL(MAX) }
$$



SMD product packs 32 BOX=The outside box packs ( 3000 PCS $* 32$ BOX $=96000 \mathrm{PCS}$ )(MAX)

| Accurate Kinetic Energy |  | CUST. P/N |  |
| :---: | :---: | :---: | :---: |
|  |  | Aker Approved P/N : CXA- | 12000-3F4D40 |
|  |  | APPROVED : Xtal | SHEET : 8 of 9 |
|  |  | PREPARED : Sandy | REV . |
| 9. MECHANICAL PERFORMANCE |  |  |  |
| TEST ITEMS | TEST METHODS AND TEST CONDITION |  | PERFORMANCE |
| 9.1 Drop Test | The specimen is measured for its frequency and resistance before the test. It is then dropped from a hight of 100 cm or more as a free fall object onto a hard wooden plate of 30 mm or more in thickness. ( in accordance with JIS-C0044 ) |  | To satisfy the electrical performance . |
| 9.2 Vibration Test | The specimen is measured for its frequency and resistance before the test. Most them into $\mathrm{X}, \mathrm{Y}$ and Z axes, respectively, for the vibration test. Vibration condition: <br> Frequency range ; 20~2000HZ <br> Peak to peak amplitude : 1.52 mm <br> Peak acceleration : 20G <br> Sweep time : 20 minute / axis <br> Pendicular total test time : 4 hours <br> ( in accordance with MIL-STD-883F: 2007.3 ) |  |  |
| 9.3 Resistance to Soldering Test | The specimen is measured for its frequency and resistance before the test. Place the specimen on the belt of the converynace and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place,the specimen under the referee condition for $-\sim 2$ hours and then measure its electrical performance. <br> Temperature Condition of IR Simulation: <br> The temperature range of the preheated section is setted at $150 \sim 180^{\circ} \mathrm{C}$ for $60 \sim 120 \mathrm{sec}$. For the next section the temperature range is setted at $217 \sim 260^{\circ} \mathrm{C}$ for $45 \sim 90 \mathrm{sec}$. and within this time range the specimen should be able to sustain at the peak temperature, $260+/-3^{\circ} \mathrm{C}$, for 10 sec long. <br> ( in accordance with JESD22-B106-B ) |  |  |
| 9.4 Fine Leak Test | Place the specimen in a pressurized container and pressurize it with the detection gas ( mixed gas consisting of $95 \%$ or more helium ) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container. <br> ( in accordance with MIL-STD-883F : 1014.11 ) |  | Less than $1.0 * 10^{-8} \mathrm{~atm} . c . c . / \mathrm{sec}$, Helium |
| The referee condition.Temperature $25 \pm 2{ }^{\circ} \mathrm{C}$Humidity $\quad 44 \sim 55 \%$Pressure $\quad 86 \sim 106 \mathrm{kPa}$(in accordance with MIL-STD-883E : 1014.9 ) |  |  |  |


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|  |  | Aker Approved P/N : CXA-012 | 0-3F4D40 |
|  |  | APPROVED : Xtal | SHEET : 9 of 9 |
| Accurate | etic Energy | PREPARED : Sandy | REV . : 1 |
| 10. CLIMA | C RESIST | CE |  |
| TEST ITEMS | TEST METHOD | AND TEST CONDITION | PERFORMANCE |
| 10.1 Low Temp Exposure Test | The specimen is resistance before Place the specime at the temperatur Take the specime and measure itsel leaving $1 \sim 2$ hou ( in accordance | easured for its frequency and he test . <br> in the chamber and kept it of $-40 \pm 3^{\circ} \mathrm{C}$ for $168 \pm 6$ hours . out of the chamber trical performance after under the referee condition. with JIS-C0020 ) |  |
| 10.2 Aging Test | The specimen is resistance before Place the specime at the temperatur And then take the measure its electric for 1 ~ 2 hours ( in accordance | easured for its frequency and e test . <br> in the testing chamber and keep it of $+125 \pm 3^{\circ} \mathrm{C}$ for $720 \pm 48$ hours. specimen out of the chamber and al performance after leaving der the referee condition. with JIS-C0021 ) | satisfy the electrical <br> formance . |
| 10.3 High <br> Temperature \& High Humidty | The specimen is and resistance be Place the specime kept it at the tem humidity of $85 \pm$ then take the spe electrical perform hours under the r ( in accordance | easured for its frequency re the test . <br> in the testing chamber and rature of $+85 \pm 5^{\circ} \mathrm{C}$ and $\%$ for $168 \pm 6$ hours.and men out and measure its nce after leaving for $1 \sim 2$ eree condition. <br> with MIL-STD-883F : 1004.7 ) |  |
| 10.4 Temperature Cycle Test | The specimen is and resistance be Subject the speci temperature rang <br> Measure its elect for 1 ~ 2 hours ( in accordance | asured for its frequency re the test . <br> en to the 100 cycles of stated below . $125 \pm 3^{\circ} \mathrm{C}(15 \pm 3 \mathrm{~min})$. <br> 2~3 min. <br> Low temp. $-55 \pm 3{ }^{\circ} \mathrm{C}(15 \pm 3 \mathrm{~min})$. <br> al performance after leaving it nder the referee condition . with MIL-STD-883F : 1010.8 ) |  |

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[^0]:    *Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.*

